

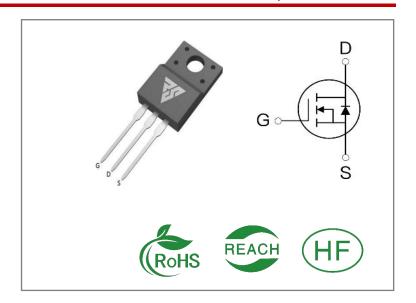
ID	R <sub>DS</sub> (ON)(Typ)	VDSS
9A	420mΩ	800V

## **Applications:**

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)
- AC-DC Switching Power Supply

#### **Features:**

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability



**Ordering Information** 

Part Number	Package	Marking	Packing	Qty.
RS80R500F	T0-220F	RS80R500F	Tube	50 PCS

## Absolute Maximun Ratings Tc= 25℃ unless otherwise specified

Symbol	Parameter	RS80R500F	Units
VDSS	Drain-to-Source Voltage	800	V
ID	Continuous Drain Current TC=25℃	9	
ID	Continuous Drain Current TC=100℃	5.5	Α
IDM	Pulsed Drain Current (Note*1)	27	
PD	Power Dissipation	52	W
VGS	Gate- to- Source Voltage	±30	V
EAS	Single Pulse Avalanche Engergy L=10mH,VDS= 50V, RG = 25 $\Omega$ , TC=25 $^{\circ}$ C	270	mJ
dv/dt	MOSFET dv/ dt ruggednessVDS = 0400V	50	V/ns
dv/dt	Reverse diode dv/dt VDS = 0400V, Tj = 25°C, ISD≤ID	15	V/ns
TL TPKG	Maximum Temperature for Soldering  Leads at 0.063in(1.6mm)from Case for 10 seconds  Package Body for 10 seconds	300 260	$^{\circ}$
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

<sup>\*</sup> Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



## **Thermal Resistance**

Symbol	Parameter	RS80R500F	Units	Test Conditions
RÐJC	Junction-to-Case	2.4	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^{\circ}\mathrm{C}$
RθJA	Junction-to- Ambient	67		1 cubic foot chamber,free air.

# **OFF Characteristics** TJ= 25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	800			V	VGS=0V,ID=250μ A
IDSS	Drain- to- Source Leakage Current			1	μΑ	VDS=800V,VGS= 0V
IGSS	Gate- to- Source Forward Leakage			100	- A	VGS=30V ,VDS=0 V
1033	Gate- to- Source Reverse Leakage			-100	nA	VGS=-30V ,VDS= 0V

# ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance(Note*2)		420	500	mΩ	VGS=10V,ID=4.5 A
VGS(TH )	Gate Threshold Voltage	2.5		4.5	V	VGS=VDS,ID=25 0μA

# Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		28			
trise	Rise Time		34		C	VDS=400V
td(OFF)	Turn- OFF Delay Time		100		nS	ID=9A RG=25Ω
tfall	Fall Time		28			



**Dynamic Characteristics** Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		1099			VGS=0V
Coss	Output Capacitance		52		pF	VDS=100V
Crss	Reverse Transfer Capacitance		1			f=1.0MHz
Qg	Total Gate Charge		24.6			VDS=400V
Qgs	Gate- to- Source Charge		5.6		nC	ID=9A
Qgd	Gate-to-Drain(" Miller") Charge		9			VGS=10V

### **Source-Drain Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			9	Α	Integral pn- diode
ISM	Maximum Pulsed Current			27	Α	in MOSFET
VSD	Diode Forward Voltage			1.3	V	IS=9A,VGS=0V
trr	Reverse Recovery Time		258		nS	VR=100V
Qrr	Reverse Recovery Charge		3.15		μC	IS=9A,di/dt=100A /μs

### Notes:

<sup>\* 1.</sup> Repetitive rating, pulse width limited by maximum junction temperature.

<sup>\* 2.</sup> Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 2%



### **Typical Feature Curve**

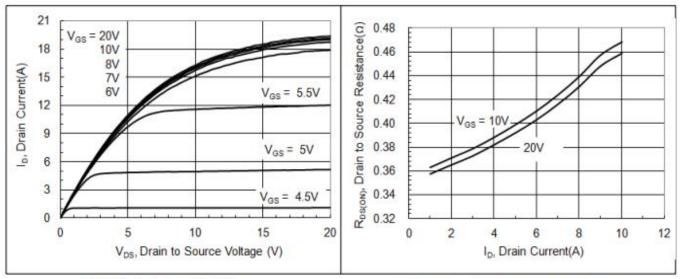


Fig1. Output characteristics

Fig2. Drain-source on-state resistance

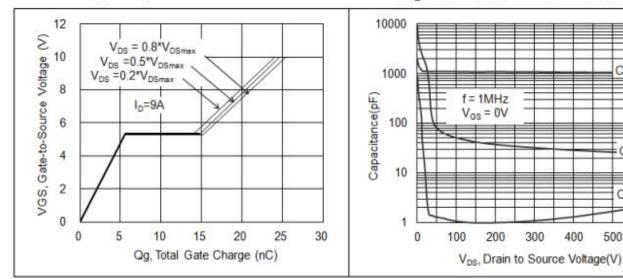


Fig3. Gate charge characteristics

1.12 Drain to Source Voltage I<sub>D</sub> =250uA 1.08 (Normalized) 1.04 0.96 BV<sub>DS</sub>, 0.92 0.88 -80 -40 0 40 80 120 160 T<sub>J</sub>, Junction Temperature (°C)

Fig 4. Capacitance Characteristics

400

500

600

Fig 5. RDS(ON) vs junction temperature

40

T<sub>J</sub>, Junction Temperature(°C)

80

120

Fig 6. BVpss vs junction temperature

2.8

2.4

2

1.2

0.8

0.4

-80

-40

I<sub>D</sub> =4.5A

Roscon, Drain to Source Resistance

(Normalized) 1.6

160



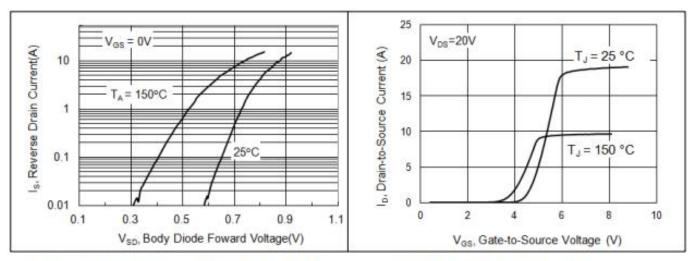


Fig 7. Forward characteristics of reverse diode

Fig 8. Transfer characteristics

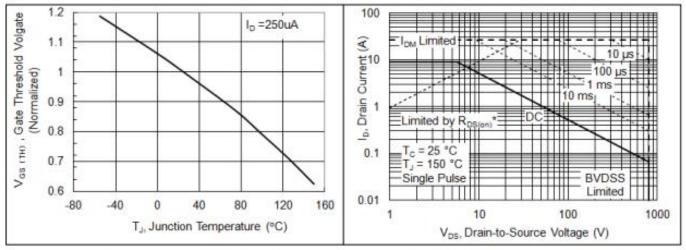


Fig 9. V<sub>GS(TH)</sub> vs junction temperature

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Fig 10. Safe operating area(TO-220F)

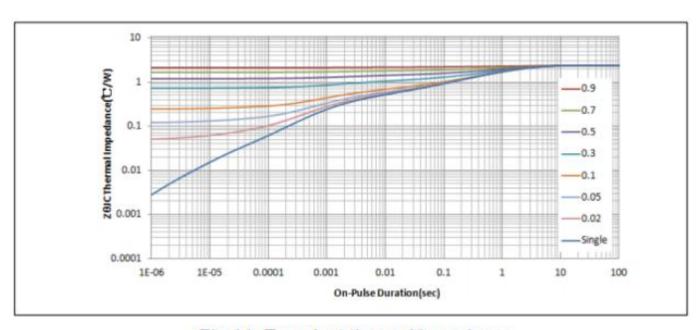


Fig 11. Transient thermal impedance



## **Test Circuits and Waveforms**

Figure A: Gate Charge Test Circuit and Waveform

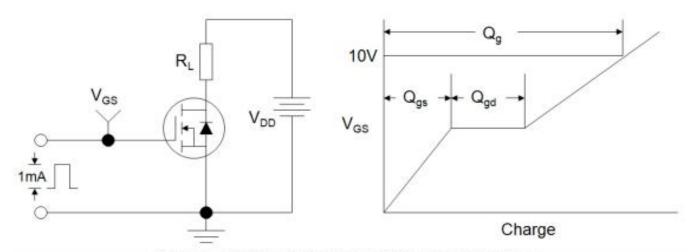


Figure B: Resistive Switching Test Circuit and Waveform

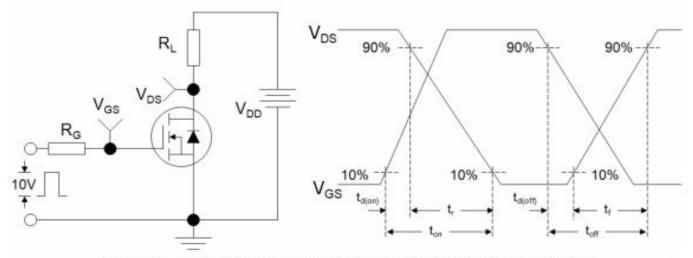
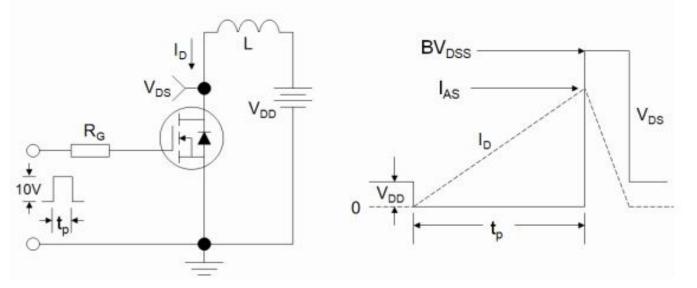
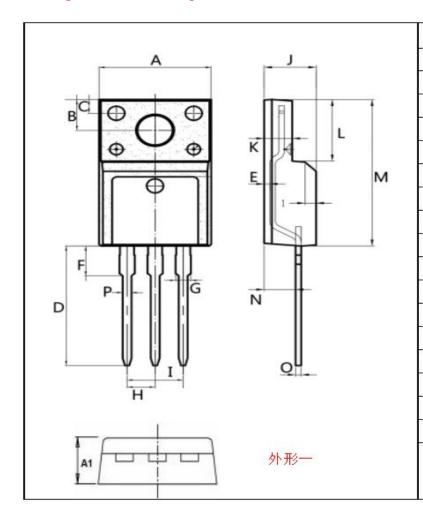


Figure C: Unclamped Inductive Switching Test Circuit and Waveform

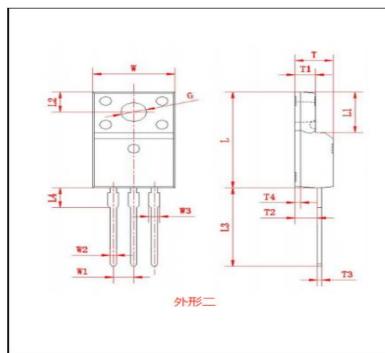




# Package outline drawing(TO-220F Unit: mm)



Min.	Max.
9.95	10.36
4.5	5.0
2.95	3.25
1.25	1.45
12.60	13.60
0.40	0.60
2.8	3.5
1.30	1.45
(2.54	1)
(5.08	3)
4.60	4.75
2.45	2.65
6.5	6.8
15.4	16.0
2.25	3.05
0.45	0.55
0.70	0.90
	9.95 4.5 2.95 1.25 12.60 0.40 2.8 1.30 (2.54 (5.08 4.60 2.45 6.5 15.4 2.25 0.45



Dim.	Min.	Max.
W	9.95	10.36
W1	(2.5	4)
W2	0.70	0.90
W3	1.25	1.47
L	15.67	16.07
L1	6.48	6.88
L2	3.2	3.4
L3	12.6	13.6
L4	(3.23	3)
Т	4.50	4.90
T1	2.34	2.74
T2	2.25	2.95
T3	0.45	0.60
T4	(0.	70)
G	3.08	3.28

All Dimensions in millimeter



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